Searcn Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/771,788	ESPIAU ET AL.	
Examiner	Art Unit .	
David H. Vu	2821	

SEARCHED				
Class	Subclass	Date	Examiner	
UPDATED	ABOVE	1/4/2008	DV	
313	634		1	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH(SI	ERENCE EE SEARCH PRINTOUT)	1/4/2008	DV	

DATE	EXMR
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